



Application/Control No.	Applicant(s)/Patent under Reexamination
10/761,289	CHIU ET AL.
Examiner	Art Unit
Bena Miller	3725

	SEAR	CHED	
Class	Subclass	Date	Examiner
144	144.51	8/30/2005	ввм
	144.52		
	144.1		
	145.1		
	372,371		
269	1,901		
	295		
409	178,179		
108	143		
384	55,57,69		
	42		
33	562,427		
	464,478		
	374	$\mathcal{U}$	

INTERFERENCE SEARCHED					
Class	Subclass	Date		Examiner	
144	144.51	8/30/2005		ввм	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Search by Bob Watson, class 269, xr 269/1,901	8/17/2005	ввм
Search by Dan Howell, class 409 xr 409/178	8/17/2005	ввм
Search by Janet Wilkens, class 108	8/30/2005	ввм
Search by Hannon, class 384	8/29/2005	ВВМ
Search by Christopher Fulton, class' 33	8/31/2005	ВВМ
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Search Notes (continued)



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